TOSHIBA Transistor Silicon PNP Epitaxial Type

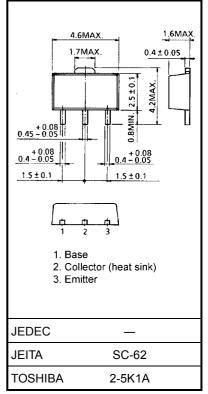
# 2SA2066

# High-Speed Switching Applications DC-DC Converter Applications

- High DC current gain:  $h_{FE} = 200$  to 500 (I<sub>C</sub> = -0.2 A)
- Low collector-emitter saturation voltage:  $V_{CE}$  (sat) = -0.19 V (max)
- High-speed switching:  $t_f = 25 \text{ ns}$  (typ.)

## Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V <sub>CBO</sub>	-20	V	
Collector-emitter voltage		V <sub>CEO</sub>	-10	V	
Emitter-base voltage		V <sub>EBO</sub>	-7	V	
Collector current	DC	Ι <sub>C</sub>	-2.0	А	
	Pulse	I <sub>CP</sub>	-3.5	~	
Base current		Ι <sub>Β</sub>	-200	mA	
Collector power dissipation	t = 10 s	P <sub>C</sub>	2.0	W	
	DC	(Note 1)	1.0		
Junction temperature		Tj	150	°C	
Storage temperature range		T <sub>stg</sub>	-55 to 150	°C	



Note 1: Mounted on FR4 board (glass epoxy, 1.6 mm thick, Cu area:  $645 \text{ mm}^2$ )

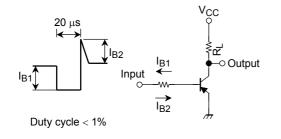
#### Weight: 0.05 g (typ.)

### **Electrical Characteristics (Ta = 25°C)**

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Collector cut-off current		I <sub>CBO</sub>	$V_{CB} = -20 V, I_E = 0$	_	_	-0.1	μA	
Emitter cut-off current		I <sub>EBO</sub>	V <sub>EB</sub> = -7 V, I <sub>C</sub> = 0	_	_	-0.1	μA	
Collector-emitter breakdown voltage		V (BR) CEO	I <sub>C</sub> = −10 mA, I <sub>B</sub> = 0	-10	—	_	V	
DC current gain		h <sub>FE</sub> (1)	V <sub>CE</sub> = -2 V, I <sub>C</sub> = -0.2 A	200	_	500		
		h <sub>FE</sub> (2)	V <sub>CE</sub> = -2 V, I <sub>C</sub> = -0.6 A	125	_	_		
Collector-emitter saturation voltage		V <sub>CE (sat)</sub>	I <sub>C</sub> = -0.6 A, I <sub>B</sub> = -0.02 A	_	_	-0.19	V	
Base-emitter saturation voltage		V <sub>BE (sat)</sub>	I <sub>C</sub> = -0.6 A, I <sub>B</sub> = -0.02 A	_	_	-1.1	V	
Switching time	Rise time	tr	See Figure 1 circuit diagram.	_	50	_	ns	
	Storage time	t <sub>stg</sub>	V <sub>CC</sub> ≈ −6 V, R <sub>L</sub> = 10 Ω	_	115	_		
	Fall time	t <sub>f</sub>	−I <sub>B1</sub> = I <sub>B2</sub> = −20 mA	—	25	—		

Unit: mm

Marking



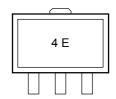
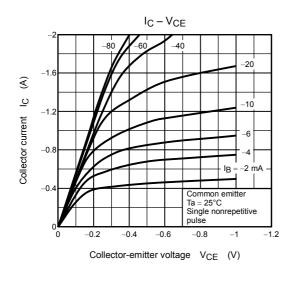
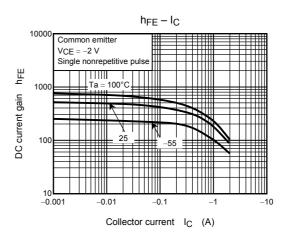
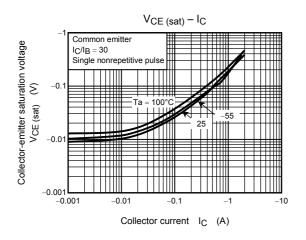


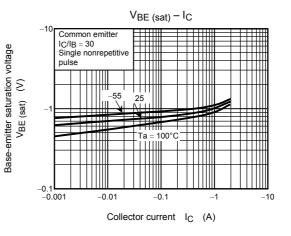
Figure 1 Switching Time Test Circuit & Timing Chart

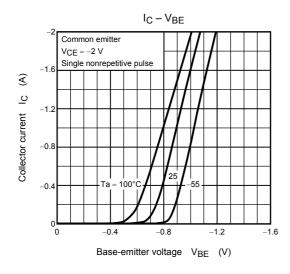
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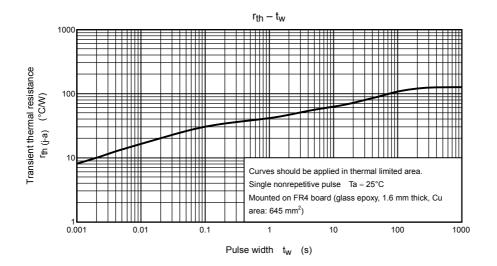












Safe Operating Area -10 IC max (pulsed) • \_10 ms • \_1 ms • 100 μs • IC max (continuous) ٦IJ Πŀ € ms∢\* **- 10** s∢\* **- 10** 100 ms • <u>ں</u> Collector current DC operation (Ta = 25°C) ♦: Single nonrepetitive pulse Ta = 25°C Note that the curves for 100 ms\* 10 s\* and DC operation\* will be different when the devices aren't mounted on an FR4 board (glass epoxy, 1.6 mm thick, Cu area: 645 mm<sup>3</sup>). These characteristic curves must be derated linearly with increase in temperature. -0.1 max VCEO r -0.01 -0.1 -10 -100 -1 Collector-emitter voltage  $V_{CE}$  (V)

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